Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	г
10/649,829	TAKI ET AL.	
Examiner	Art Unit	
Minh Nauven	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB), See printout	8/3/2004	MN		
Limited search (327/113,114,455/130-131,302-308, 313-316,296, 227, 334, 318, 210,258-266), see printout	8/3/2004	MN		
Updated	10/13/2005	MN		
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